### APG045N10GH N-Channel Enhancement Mosfet

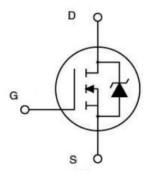
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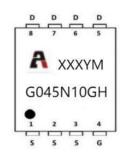
## Features

- 100V,120A
  R<sub>DS (ON)</sub> <4.5m Ω @V<sub>GS</sub>=10V TYP:3.8m Ω
- Split Gate Trench Technology
- Extremely low switching loss
- Excellent stability and uniformity

### **Applications**

- High Frequency Switching
- Synchronous Rectification





#### Marking and pin Assignment

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
G045N10GH	APG045N10GH	PDFN5X6	-	-	5000

## ABSOLUTE MAXIMUM RATINGS (TJ=25℃ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	100	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current (Tc=25°C) <sup>(1)</sup>	Ι <sub>D</sub>	120	A
Continuous Drain Current (Tc=100°C)	ID	76	A
Pulsed Drain Current <sup>(2,3)</sup>	Ідм	480	А
Drain Power Dissipation <sup>(1)</sup>	PD	123	W
Single Pulsed Avalanche Energy $(V_{DS}=50V,L=0.5mH)$	E <sub>AS</sub>	598	mJ
Thermal Resistance from Junction to Case <sup>(1)</sup>	R <sub>ejc</sub>	1.02	°C/W
Thermal Resistance from Junction to Ambient <sup>(1)</sup>	R <sub>0JA</sub>	62	°C/W
Junction Temperature	TJ	-55~ +150	°C
Storage Temperature	T <sub>STG</sub>	-55~ +150	°C

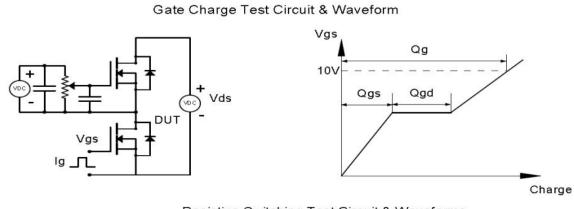
## MOSFET ELECTRICAL CHARACTERISTICS(TJ=25℃ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Туре	Max	Unit
Static Characteristics				· · · ·		
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> =250µA	100	-	-	V
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> = 0V	-	-	1	μA
Gate-body leakage current	I <sub>GSS</sub>	$V_{GS}$ = ±20V, $V_{DS}$ = 0V	-	-	±100	nA
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2	3	4	V
Drain-source on-resistance <sup>(4)</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =50A	-	3.8	4.5	mΩ
Forward transconductance	<b>g</b> fs	V <sub>DS</sub> =10V, I <sub>D</sub> =10A	-	31	-	S
Dynamic characteristics <sup>(5)</sup>	•					
Input Capacitance	Ciss		-	3310	-	pF
Output Capacitance	Coss	V <sub>DS</sub> =50V, VGS=0V, f=1MHz	-	1001	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	18	-	
Switching characteristics <sup>(5)</sup>			·	-		
Turn-on delay time	t <sub>d(on)</sub>		-	13.5	-	nS
Turn-on rise time	tr	$V_{DD}$ =50V, $I_{D}$ =20A, $R_{G}$ =3 $\Omega$ ,	-	15.7	-	
Turn-off delay time	t <sub>d(off)</sub>	V <sub>GS</sub> =10V	-	28	-	
Turn-off fall time	t <sub>f</sub>	-	-	13.8	-	
Total Gate Charge	Qg		-	55	-	
Gate-Source Charge	Qgs	V <sub>DS</sub> =50V, I <sub>D</sub> =20A, V <sub>GS</sub> =10V	-	16.4	-	nC
Gate-Drain Charge	Qgd	- V <sub>GS</sub> -10V	-	16.4	-	
Source-Drain Diode characteristics	•		•	•		
Diode Forward voltage <sup>(4)</sup>	V <sub>SD</sub>	TJ=25℃, V <sub>GS</sub> =0V, I <sub>S</sub> =50A	-	-	1.2	V
Diode Forward current	ls	Tc=25℃	-	-	120	А
Body Diode Reverse Recovery Time	trr		-	54.8	-	nS
Body Diode Reverse Recovery Charge	Qrr	TJ=25℃, I⊧=20A,di/dt=100A/us	-	61.6	-	nC

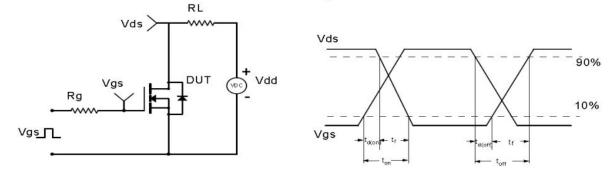
#### Notes:

- 1) Surface Mounted on 1 in<sup>2</sup> pad area, t  $\leq$  10 sec
- 2) Pulse width  $\leq$  10µs, duty cycle  $\leq$  1 %
- 3) Limited by bonding wire
- 4) Pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%
- 5) Guaranteed by design, not subject to production testing

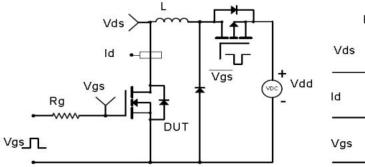
#### **Test Circuit & Waveform**

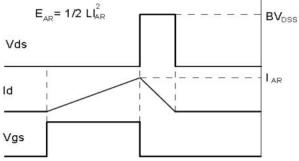


Resistive Switching Test Circuit & Waveforms

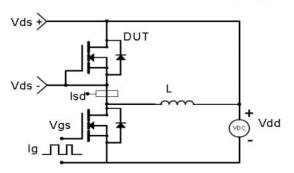


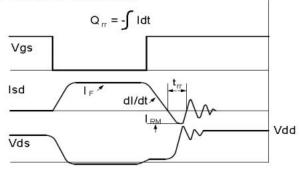
#### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





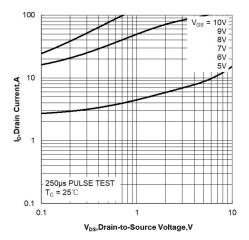
#### Diode Recovery Test Circuit & Waveforms







## **Typical Characteristics**



#### Figure 1. Output Characteristics

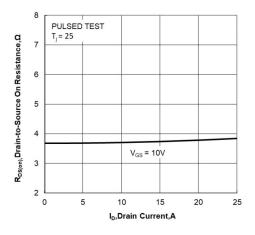


Figure 3. Drain-to-Source On Resistance vs Drain Current

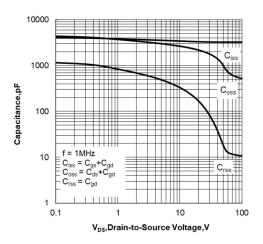
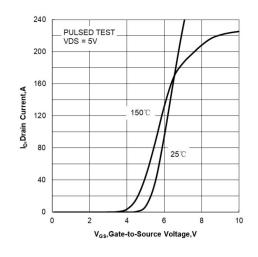


Figure 5. Capacitance Characteristics



#### Figure 2. Transfer Characteristics

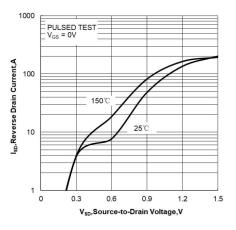


Figure 4. Body Diode Forward Voltage vs Source Current and Temperature

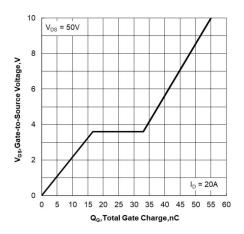
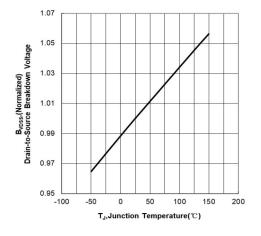
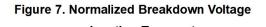


Figure 6. Gate Charge Characteristics

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# **Typical Characteristics**





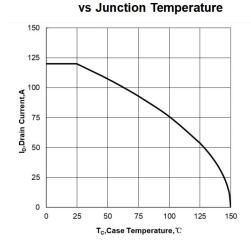


Figure 9. Maximum Continuous Drain Current

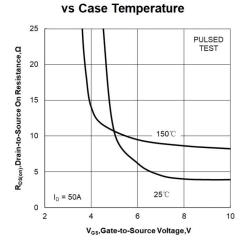


Figure 11. Drain-to-Source On Resistance vs Gate Voltage and Drain Current

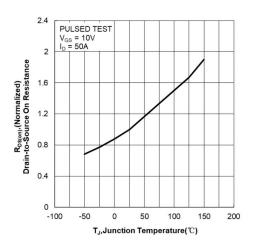


Figure 8. Normalized On Resistance vs

Junction Temperature

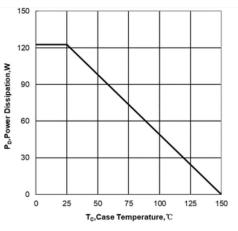


Figure 10. Maximum Power Dissipation

vs Case Temperature

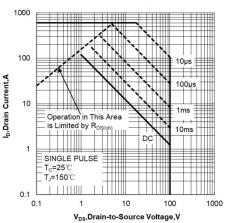


Figure 12. Maximum Safe Operating Area



## **Typical Characteristics**

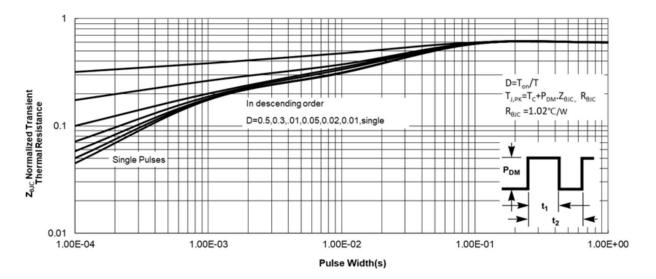
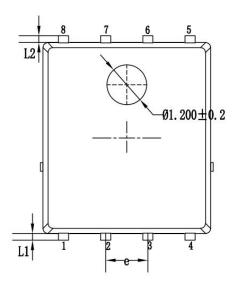
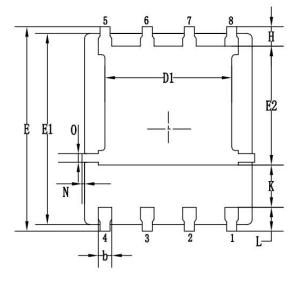


Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

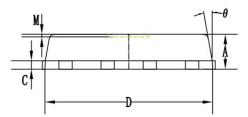
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## PDFN5X6 Package Information





0 1 1	Millimeters			
Symbols	MIN.	NOM.	MAX.	
A	0.90	1.05	1.20	
b	0.34	0.40	0. 50	
C	0.20	0. 25	0.35	
D	4.80	5.05	5. 20	
D1	3.72	3.82	3.92	
Е	5.95	6.15	6. 30	
E1	5.60	5.75	5.90	
E2	3.47	3. 57	3.67	
е	1.27 BSC.			
H	0.48	0. 58	0.68	
K	1.17	1.27	1.37	
L	0.64	0.74	0.84	
L1/L2	0.20 REF.			
θ	8°	10°	12°	
M	0.08 REF.			
N	0	-	0.15	
0	0.25 REF.			





## **Revision History**

Revision	Release	Remark
V1.0	2024/04/10	Initial Release

## Disclaimer

The information given in this document describes the independent performance of the product,but similar performance is not guaranteed under other working conditions,and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Allpower assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which

requires high reliability.Customers using or selling these products for use in medical,life-saving,or lifesustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.